

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/718,625	CHA ET AL.	
Examiner	Art Unit	
Rita R. Patel	1746	

	SEAR	CHED	
Class	Subclass	Date	Examiner
134	56R	1/3/2007	RRP
134	57R	1/3/2007	RRP
134	109	1/3/2007	RRP
700	all	1/3/2007	RRP
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor's search.	1/3/2007	RRP		
EAST key word search.	1/3/2007	RRP		
Claim interpretation re intended use and restriction requirement aided by Examiner J. Perrin.	12/29/2007	RRP		
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